

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/721,744	YATES ET AL.	
				Examiner	Art Unit	
				DUNG A. LE	2818	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
257	695	3/15/2005	DLE	IEEE, JPO, EPO, PGPUB, IBM, EAST	3/15/2005	DLE
	629					
	295296					
438	003					
	257-259					
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner		DATE	EXMR